

**Notice of References Cited**

Application/Control No.

10/552,497

Applicant(s)/Patent Under  
Reexamination  
HANSEN ET AL.

Examiner

Binh X. Tran

Art Unit

1792

Page 1 of 1

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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